Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10661225	NGUYEN ET AL.
Examiner	Art Unit
Nguyen, Hiep	2816

SEARCHED					
327	175, 18, 20, 26	01-25-07	Hn		

SEARCH NOTES					
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INTERFERENCE SEARCH						
Class		Subclass	Date	Examiner		
327	171-176		09-20-07	Hn		